

<b>Notice of References Cited</b>	Application/Control No. 10/563,122	Applicant(s)/Patent Under Reexamination MEYER, MATTHIAS	
	Examiner AIMEE LI	Art Unit 2183	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,860,092 A	01-1999	Breid et al.	711/118
*	B	US-5,897,656 A	04-1999	Vogt et al.	711/141
*	C	US-5,907,716 A	05-1999	Yoshimura, Noritsugu	710/54
*	D	US-6,574,711 B2	06-2003	Sumita, Masaya	711/129
*	E	US-2003/0196038 A1	10-2003	Sumita, Masaya	711/119
*	F	US-6,751,583 B1	06-2004	Clarke et al.	703/17
*	G	US-2004/0184470 A1	09-2004	Holden, Roger John	370/412
*	H	US-6,895,579 B2	05-2005	Lueh, Guei-Yuan	717/148
*	I	US-7,260,683 B2	08-2007	Sumita, Masaya	711/129
*	J	US-7,444,475 B2	10-2008	Sumita, Masaya	711/129
*	K	US-7,454,555 B2	11-2008	Ware et al.	711/5
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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